Receipt date: 04/21/2009

10542040 PT GAU 13795 Approved for use through 04/30/2009. OMB 0651-0031

Doc description: Information Disclosure Statement (IDS) Filed

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Not for submission under 37 CFR 1.99)

Application Number		10542040			
Filing Date		2006-02-06			
First Named Inventor	John	Mize			
Art Unit		1795			
Examiner Name Jasor		n Berman			
Attorney Docket Number		H0004870.70759 US -4015			

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Receipt date: 04/21/2009	Application Number		10542040	0542040 - GAU: 179
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Filing Date 2006-02-06

First Named Inventor John Mize

Art Unit 1795

Examiner Name Jason Berman

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Application Number		10542040 GAO. 179
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Examiner Signature /Jason Berman/					n/			Date Considered	07/15/2009	
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4 Kind of document by the appropriate symbols as indicated on the document under WiPO Standard ST.16 if possible. 5 Applicant is to place a check mark here if

English language translation is attached.